

半導體超微量分析中心

Ultra Trace Analysis Service Center of Semiconductor

日期: 2024年12月04日

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測試報告

報告編號: DNP24B00008

台灣范特希科技有限公司

台北市中正區仁愛路2段25號

以下測試之樣品係由申請廠商所提供及確認:

產品名稱: 窗濾機

申請廠商: 台灣范特希科技有限公司

收樣日期: 2024年11月15日

測試日期: 2024年11月15日~2024年12月04日

測試結果:

測試項目	測試方法	對照組	實驗組	去除率
		μg/m³	μg/m³	%
懸浮微粒PM2.5	實驗組:將受測產品架設於1.25m×0.65m×1.25m之密閉測試	839	<1	>99.9
	空間中,注入固定濃度之粉塵並均勻混合後,以監測器連續			
	監測開機1小時後之空氣中小於2.5µm之微粒濃度變化。 (最大			
	風量:紅燈)			
	對照組:與實驗組相同之執行方式,惟獨不開啟受測產品。			
	比較實驗組與對照組,以了解受測產品對空氣中粉塵之清淨			
	能力。			

備註:

- 1. 測試報告僅就委託者之委託事項提供測試結果,不對產品合法性做判斷。
- 2. 本報告不得分離,分離使用無效。
- 3. 本次委託測試項目由SGS環境實驗室-台北執行(NPX24B00274)。

- END -

察敬廷 副理 台灣檢驗科技股份有限公司WAN 報告簽署人

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Member of the SGS Group



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樣品照片



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